

## HFS4N90-VB Datasheet **Power MOSFET**

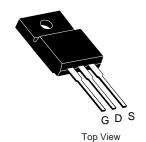
PRODUCT SUMMARY						
V <sub>DS</sub> (V)	950	)				
R <sub>DS(on)</sub> (Ω)	V <sub>GS</sub> = 10 V	2.4				
Q <sub>g</sub> (Max.) (nC)	28	8				
Q <sub>gs</sub> (nC)	5	5				
Q <sub>gd</sub> (nC)	1:	12				
Configuration	Sing	Single				

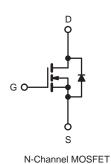
### **FEATURES**

- Dynamic dV/dt Rating
- Repetitive Avalanche Rated
- Isolated Central Mounting Hole
- Fast Switching
- Ease of Paralleling
- Simple Drive Requirements
- Compliant to RoHS Directive 2002/95/EC



#### **TO-220 FULLPAK**





<b>ABSOLUTE MAXIMUM RATINGS</b> (T <sub>C</sub> = 25 °C, unless otherwise noted)							
PARAMETER			SYMBOL	LIMIT	UNIT		
Drain-Source Voltage			$V_{DS}$	950	V		
Gate-Source Voltage			$V_{GS}$	± 20	<b></b>		
Continuous Drain Current	V <sub>GS</sub> at 10 V	T <sub>C</sub> = 25 °C	I-	6			
	VGS at 10 V	T <sub>C</sub> = 100 °C	I <sub>D</sub>	3.9	A		
Pulsed Drain Current <sup>a</sup>			I <sub>DM</sub>	24			
Linear Derating Factor				1.5	W/°C		
Single Pulse Avalanche Energy <sup>b</sup>			E <sub>AS</sub>	770	mJ		
Repetitive Avalanche Currenta			I <sub>AR</sub>	7.8	Α		
Repetitive Avalanche Energy <sup>a</sup>			E <sub>AR</sub>	19	mJ		
Maximum Power Dissipation	T <sub>C</sub> =	25 °C	P <sub>D</sub>	190	W		
Peak Diode Recovery dV/dt <sup>c</sup>			dV/dt	5.0	V/ns		
Operating Junction and Storage Temperature Range			T <sub>J</sub> , T <sub>stg</sub>	- 55 to + 150	°C		
Soldering Recommendations (Peak Temperature)	for	10 s		300 <sup>d</sup>			
Mounting Torque	6-32 or M3 screw			10	lbf ⋅ in		
				1.1	N · m		

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b.  $V_{DD} = 50$  V, starting  $T_{J} = 25$  °C, L = 23 mH,  $R_{g} = 25$   $\Omega$ ,  $I_{AS} = 7.8$  A (see fig. 12). c.  $I_{SD} \le 7.8$  A, dl/dt  $\le 140$  A/ $\mu$ s,  $V_{DD} \le 600$  V,  $T_{J} \le 150$  °C. d. 1.6 mm from case.

<sup>\*</sup> Pb containing terminations are not RoHS compliant, exemptions may apply



THERMAL RESISTANCE RATI	NGS			
PARAMETER	SYMBOL	TYP.	MAX.	UNIT
Maximum Junction-to-Ambient	R <sub>thJA</sub>	-	40	
Case-to-Sink, Flat, Greased Surface	R <sub>thCS</sub>	0.24	-	°C/W
Maximum Junction-to-Case (Drain)	R <sub>thJC</sub>	-	0.65	

<b>SPECIFICATIONS</b> (T <sub>J</sub> = 25 °C, u	IIIC33 Oti ICI WI	ise noteu)			1		
PARAMETER	SYMBOL	TES	T CONDITIONS	MIN.	TYP.	MAX.	UNIT
Static							
Drain-Source Breakdown Voltage	$V_{DS}$	V <sub>GS</sub>	$= 0 \text{ V}, I_D = 250 \mu\text{A}$	950	-	-	V
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Referenc	e to 25 °C, I <sub>D</sub> = 1 mA	-	0.98	-	V/°C
Gate-Source Threshold Voltage	$V_{GS(th)}$	V <sub>DS</sub> :	$= V_{GS}, I_D = 250 \mu A$	2.0	-	4.0	V
Gate-Source Leakage	$I_{GSS}$		$V_{GS} = \pm 20 \text{ V}$	i	-	± 100	nA
Zero Gate Voltage Drain Current	I <sub>DSS</sub>		= 800 V, V <sub>GS</sub> = 0 V V, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 125 °C	- 1	-	1 45	μA
Drain-Source On-State Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V	I <sub>D</sub> = 3.7 A <sup>b</sup>	-	2.4	-	Ω
Forward Transconductance	9 <sub>fs</sub>	V <sub>DS</sub> =	: 100 V, I <sub>D</sub> = 3.7 A <sup>b</sup>	4.5	-	-	S
Dynamic					ı		
Input Capacitance	C <sub>iss</sub>	$V_{GS} = 0 \text{ V},$ $V_{DS} = 25 \text{ V},$ $f = 1.0 \text{ MHz}, \text{ see fig. 5}$		-	816	-	
Output Capacitance	C <sub>oss</sub>			-	68	-	pF
Reverse Transfer Capacitance	C <sub>rss</sub>			-	17	-	
Total Gate Charge	Qg			-	-	28	
Gate-Source Charge	Q <sub>gs</sub>	$V_{GS} = 10 \text{ V}$ $I_D = 3.8 \text{ A}, V_{DS} = 400 \text{ V},$ see fig. 6 and 13 <sup>b</sup>		-	-	5	nC
Gate-Drain Charge	Q <sub>gd</sub>			-	-	12	
Turn-On Delay Time	t <sub>d(on)</sub>			-	15	-	
Rise Time	t <sub>r</sub>	$V_{DD} = 400 \text{ V, } I_{D} = 3.8 \text{ A,}$ $R_{g} = 6.2 \Omega, R_{D} = 52 \Omega$ see fig. $10^{b}$		-	27	-	- ns
Turn-Off Delay Time	t <sub>d(off)</sub>			-	66	-	
Fall Time	t <sub>f</sub>			-	30	-	
Internal Drain Inductance	$L_D$	Between lead, 6 mm (0.25") from package and center of die contact		-	5.0	-	-11
Internal Source Inductance	L <sub>S</sub>			-	13	-	nH
Drain-Source Body Diode Characteristic	s						•
Continuous Source-Drain Diode Current	I <sub>S</sub>	MOSFET symbol showing the integral reverse p - n junction diode		-	-	5.0	_
Pulsed Diode Forward Current <sup>a</sup>	I <sub>SM</sub>			-	-	21	A
Body Diode Voltage	V <sub>SD</sub>	$T_J = 25  ^{\circ}\text{C}, \ I_S = 3.8  \text{A}, \ V_{GS} = 0  \text{V}^{\text{b}}$		-	-	1.8	V
Body Diode Reverse Recovery Time	t <sub>rr</sub>	T <sub>J</sub> = 25 °C, I <sub>F</sub> = 3.8 A, dl/dt = 100 A/μs <sup>b</sup>		-	320		ns
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>			-	3.3		μC
Forward Turn-On Time	t <sub>on</sub>	Intrinsic tu	rn-on time is negligible (turn	on is dor	ninated b	ov I e and	[ P)

#### Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b. Pulse width  $\leq$  300 µs; duty cycle  $\leq$  2 %.



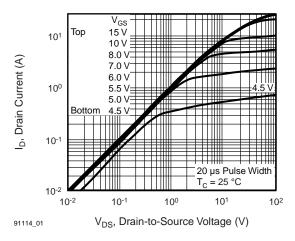


Fig. 1 - Typical Output Characteristics, T<sub>C</sub> = 25 °C

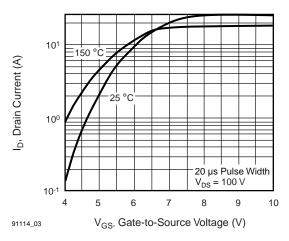


Fig. 3 - Typical Transfer Characteristics

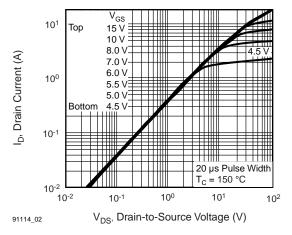


Fig. 2 - Typical Output Characteristics,  $T_C = 150 \, ^{\circ}\text{C}$ 

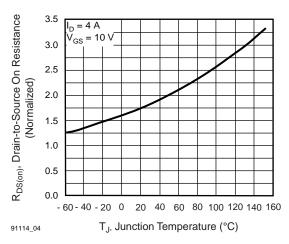


Fig. 4 - Normalized On-Resistance vs. Temperature

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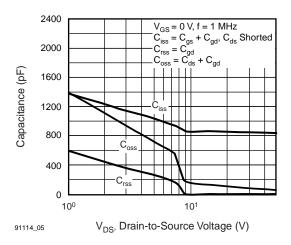


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

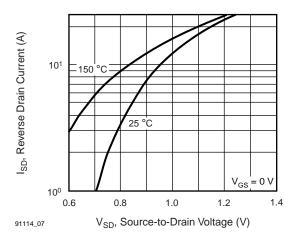


Fig. 7 - Typical Source-Drain Diode Forward Voltage

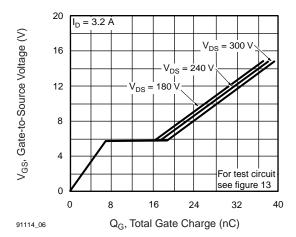


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

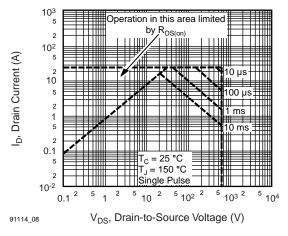


Fig. 8 - Maximum Safe Operating Area



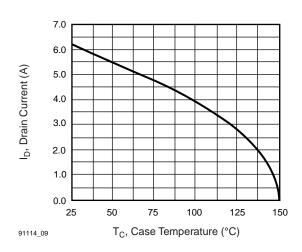


Fig. 9 - Maximum Drain Current vs. Case Temperature

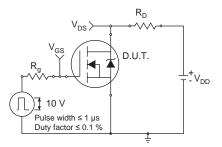


Fig. 10a - Switching Time Test Circuit

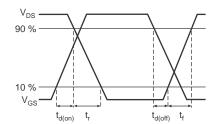


Fig. 10b - Switching Time Waveforms

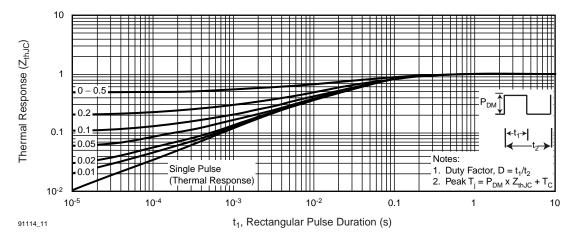


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

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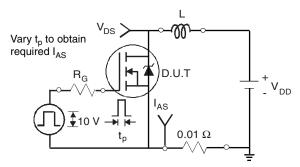


Fig. 12a - Unclamped Inductive Test Circuit

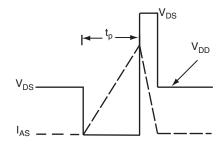


Fig. 12b - Unclamped Inductive Waveforms

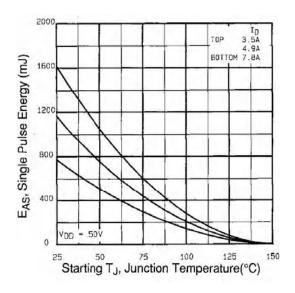


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

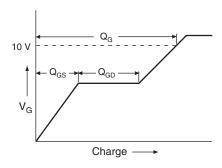


Fig. 13a - Basic Gate Charge Waveform

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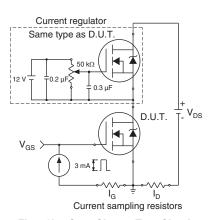
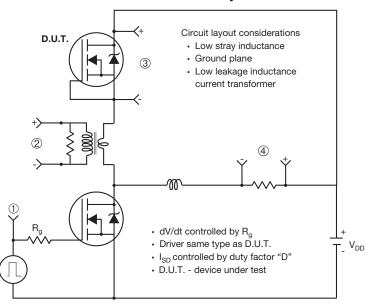


Fig. 13b - Gate Charge Test Circuit



#### Peak Diode Recovery dV/dt Test Circuit



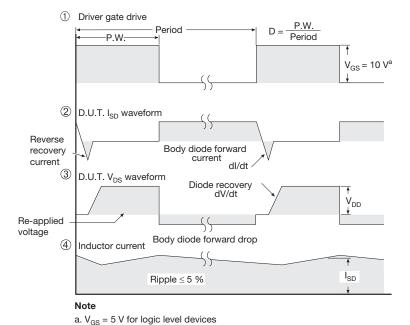
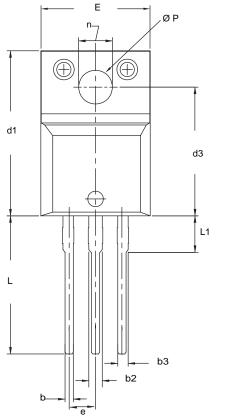
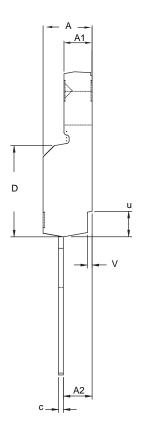


Fig. 14 - For N-Channel



### **TO-220 FULLPAK (HIGH VOLTAGE)**





DIM.	MILLIMETERS		INCHES	
	MIN.	MAX.	MIN.	MAX.
Α	4.570	4.830	0.180	0.190
A1	2.570	2.830	0.101	0.111
A2	2.510	2.850	0.099	0.112
b	0.622	0.890	0.024	0.035
b2	1.229	1.400	0.048	0.055
b3	1.229	1.400	0.048	0.055
С	0.440	0.629	0.017	0.025
D	8.650	9.800	0.341	0.386
d1	15.88	16.120	0.622	0.635
d3	12.300	12.920	0.484	0.509
E	10.360	10.630	0.408	0.419
е	2.54	BSC	0.100	BSC
L	13.200	13.730	0.520	0.541
L1	3.100	3.500	0.122	0.138
n	6.050	6.150	0.238	0.242
ØР	3.050	3.450	0.120	0.136
u	2.400	2.500	0.094	
V	0.400	0.500	0.016	0.020

ECN: X09-0126-Rev. B, 26-Oct-09 DWG: 5972

- To be used only for process drawing.
   These dimensions apply to all TO-220, FULLPAK leadframe versions 3 leads.
   All critical dimensions should C meet C<sub>pk</sub> > 1.33.
   All dimensions include burrs and plating thickness.
   No chipping or package damage.



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